

Notice of Referenc s Cited

Application/Control No.	Applicant(s)/F		
10/051,678	Reexamination LI ET AL.		
Examiner	Art Unit		
Michael S. Lebentritt	2824	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6569257	05-2003	Nguyen et al	134/26
	В	US-6,387,551	05-2002	Nishioka et al.	428/698
	С	US-6,340,435	01-2002	Bjorkman et al.	216/72
	D	US-6,273,950	08-2001	Kitabatake, Makoto	117/95
	E	US-6,064,081	05-2000	Robinson et al.	257/183
	F	US-5,965,463	10-1999	Cui et al.	438/723
	G	US-5,466,617	11-1995	Shannon, John M.	438/155
	Н	US-5,335,256	08-1994	Maruyama et al.	378/35
	1	US-5,296,258	03-1994	Tay et al.	427/96
	J	US-5,135,885	08-1992	Furukawa et al.	438/167
	κ	US-5,116,462	05-1992	Bartha et al.	216/2
	L	US-5,070,027	12-1991	Mito et al.	438/483
	М	US-4,861,533	08-1989	Bertin et al.	264/81

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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